



THORLABS PFSQ20-03-G01

NOTES/SPECIFICATIONS:

- CLEAR APERTURE: >90%
- PARALLELISM: ≤ 3arcmin
- SURFACE FLATNESS: \(\lambda/8\) AT 632.8nm OVER CLEAR APERTURE SURFACE QUALITY: 40-20 SCRATCH-DIG BACK SURFACE: FINE GROUND

- THICKNESS TOLERANCE: ±0.2 mm
- LENGTH / HEIGHT TOLERANCE: + 0.0/-0.1 mm
- COATING: PROTECTED ALUMINUM Ravg: >90% FROM 450nm - 2µm Ravg: >95% FROM 2µm - 20µm AOI: 0° TO 45°
- DAMAGE THRESHOLD: 0.3J/cm² 10ns PULSE, 10Hz AT 1064nm

FOR INFORMATION ONLY NOT FOR MANUFACTURING PURPOSES

DRAWING PROJECTION			THOR LABS		
	NAME	DATE	50.8mm x 50.8mm		
DRAWN	BAG	10/DEC/10	PROTECTED ALUMINUM MIRROR		OR
APPROVAL	DD	22/AUG/13	MATERIAL		REV
COPYRIGHT © 2010 BY THORLABS			UV FUSED SILICA		C
VALUES IN PARENTHESIS ARE CALCULATED			PFSQ20-03-G01	APPROX WE	EIGHT